

Supplementary Materials: Investigating the Nucleation of AlOx and HfOx ALD on Polyimide: Influence of Plasma Activation

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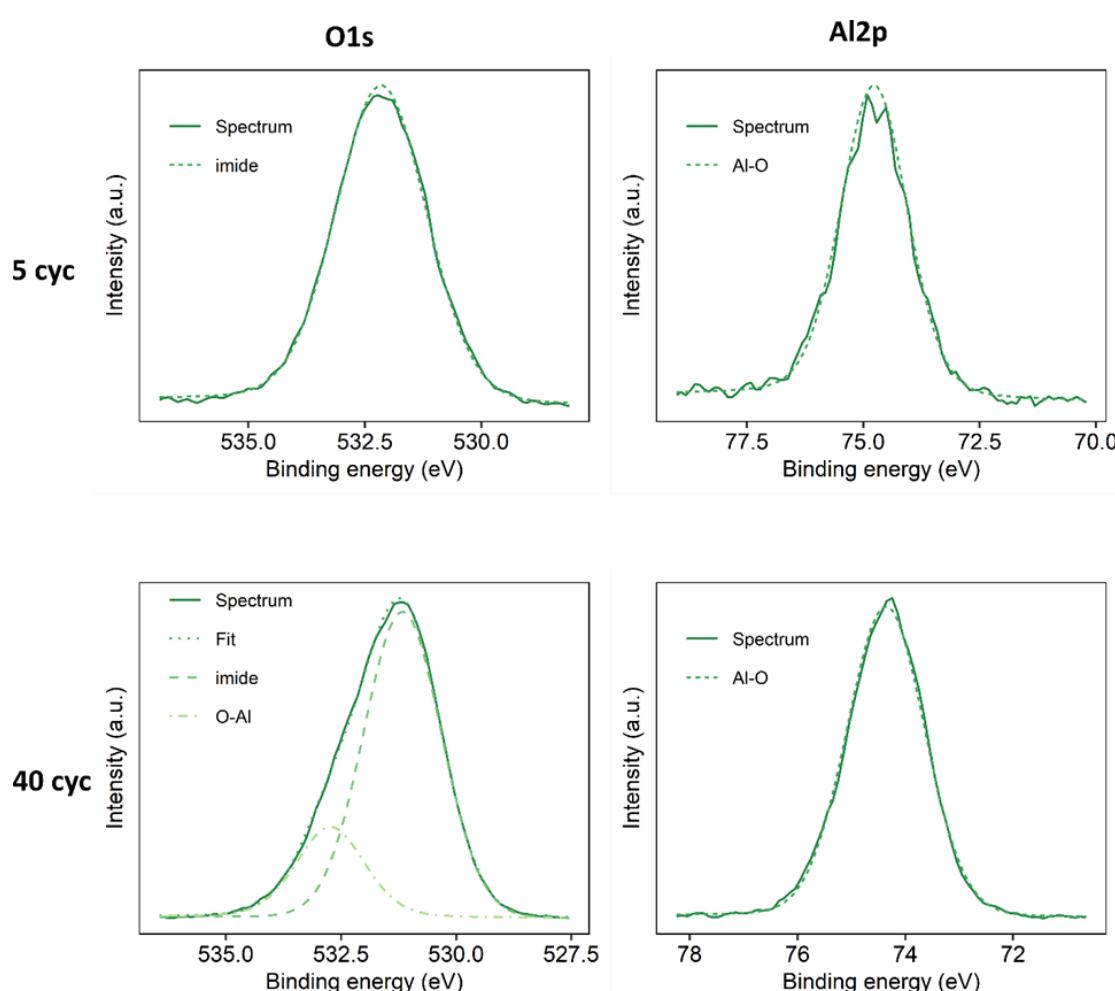


Figure S1. Peak fitting of O1s and Al2p high resolution spectra after 5 and 40 ALD cycles of Al_2O_3 on polyimide.

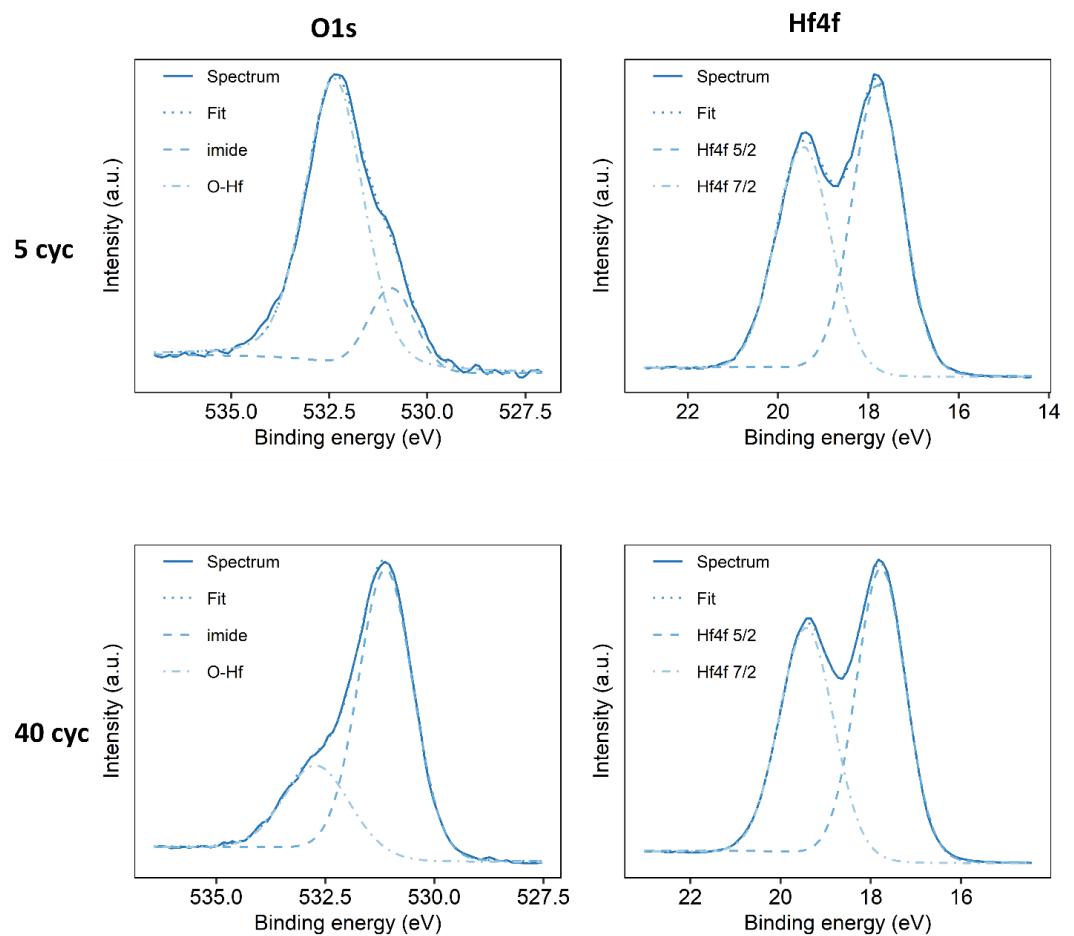


Figure S2. Peak fitting of O1s and Hf4f high resolution spectra after 5 and 40 ALD cycles of HfO_2 on polyimide.